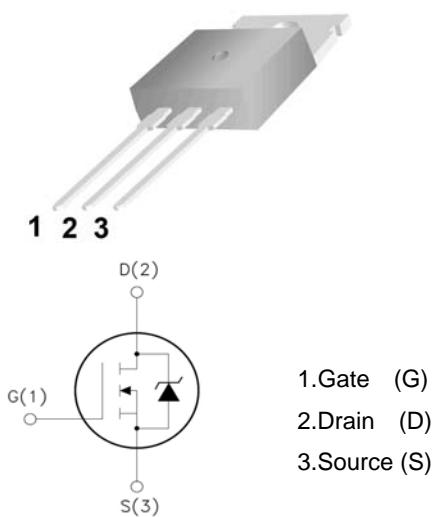




<p>Features:</p> <ul style="list-style-type: none"><input type="checkbox"/> Low Intrinsic Capacitances.<input type="checkbox"/> Excellent Switching Characteristics.<input type="checkbox"/> Extended Safe Operating Area.<input type="checkbox"/> Unrivalled Gate Charge :$Q_g = 31\text{nC}$ (Typ.).<input type="checkbox"/> $\text{BV}_{\text{DSS}}=100\text{V}, I_{\text{D}}= 30\text{A}$<input type="checkbox"/> $R_{\text{DS}(\text{on})} : 0.07\Omega$ (Max) @ $V_{\text{G}}=10\text{V}$<input type="checkbox"/> 100% Avalanche Tested	<p>TO-220</p> <p></p>  <p>1. Gate (G) 2. Drain (D) 3. Source (S)</p>
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Absolute Maximum Ratings* ($T_c=25^\circ\text{C}$ Unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_{D}	30	A
Drain Current-Continuous($T_c=100^\circ\text{C}$)	$I_{\text{D}}(100^\circ\text{C})$	12	A
Pulsed Drain Current	I_{DM}	60	A
Maximum Power Dissipation	P_{D}	55	W
Single pulse avalanche energy <small>(Note 5)</small>	E_{AS}	250	mJ
Operating Junction and Storage Temperature Range	$T_{\text{J}}, T_{\text{STG}}$	-55 To 150	$^\circ\text{C}$

Thermal Characteristics

Thermal Resistance, Junction-to-Case <small>(Note 2)</small>	$R_{\theta\text{JC}}$	2.27	$^\circ\text{C}/\text{W}$
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HGS30N10 100V N-Channel MOSFET

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	100	110	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.2	1.8	2.5	V
Drain-Source On-State Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=5\text{A}$	-	56	70	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{\text{DS}}=50\text{V}, I_{\text{D}}=9\text{A}$	12	-	-	S
Dynamic Characteristics (Note 4)						
Input Capacitance	C_{iss}	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	1350	-	PF
Output Capacitance	C_{oss}		-	240	-	PF
Reverse Transfer Capacitance	C_{rss}		-	180	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	$t_{\text{d(on)}}$	$V_{\text{DD}}=30\text{V}, I_{\text{D}}=2\text{A}, R_{\text{L}}=15\Omega$ $V_{\text{GS}}=10\text{V}, R_{\text{G}}=2.5\Omega$	-	13.8	-	nS
Turn-on Rise Time	t_{r}		-	9.3	-	nS
Turn-Off Delay Time	$t_{\text{d(off)}}$		-	43.8	-	nS
Turn-Off Fall Time	t_{f}		-	11.4	-	nS
Total Gate Charge	Q_{g}	$V_{\text{DS}}=30\text{V}, I_{\text{D}}=3\text{A}, V_{\text{GS}}=10\text{V}$	-	31	-	nC
Gate-Source Charge	Q_{gs}		-	6.4	-	nC
Gate-Drain Charge	Q_{gd}		-	9.4	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=9\text{A}$	-	-	1.2	V
Diode Forward Current (Note 2)	I_{S}		-	-	30	A
Forward Turn-On Time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec.
3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production
5. EAS condition : $T_j=25^\circ\text{C}, V_{\text{DD}}=50\text{V}, V_{\text{G}}=10\text{V}, L=0.5\text{mH}, R_{\text{G}}=25\Omega$



Typical Electrical and Thermal Characteristics (Curves)

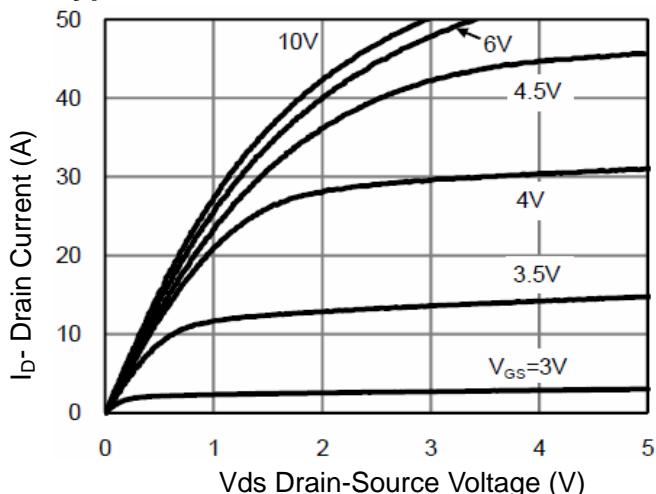


Figure 1 Output Characteristics

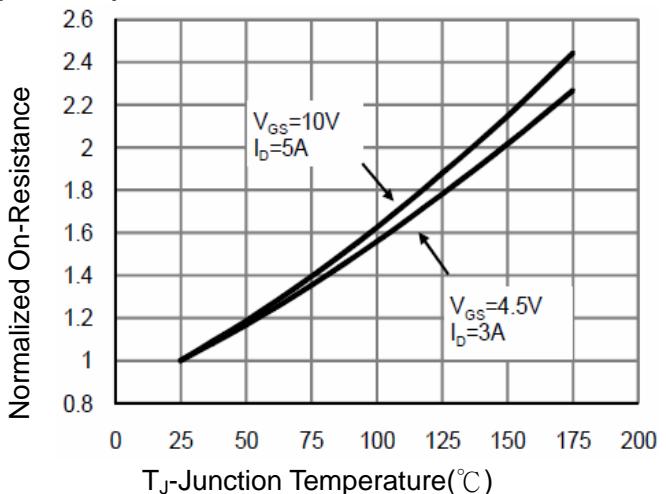


Figure 4 R_{DSON} -JunctionTemperature

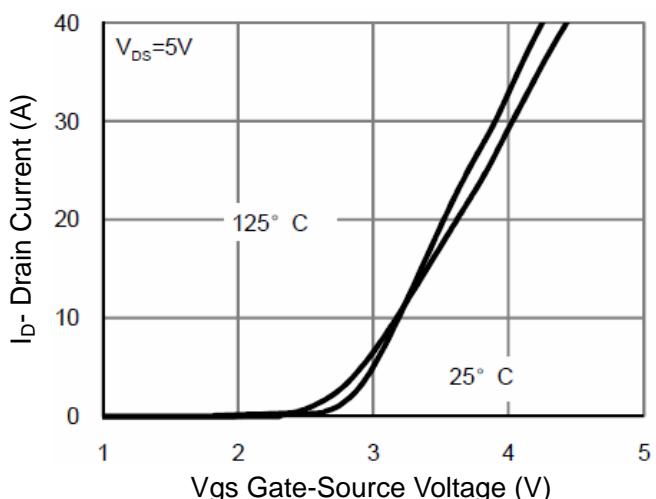


Figure 2 Transfer Characteristics

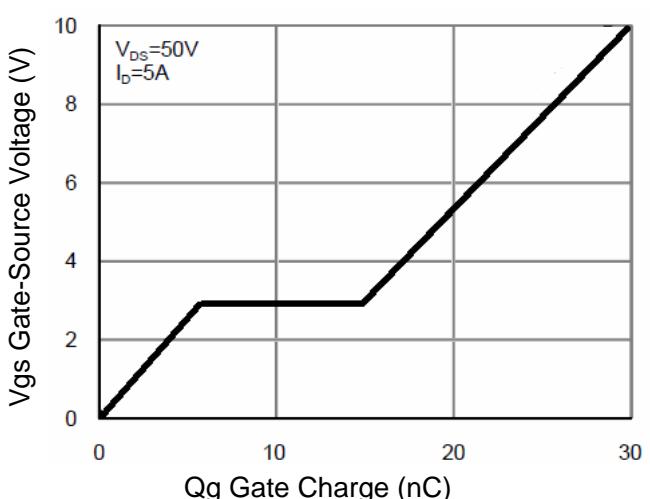


Figure 5 Gate Charge

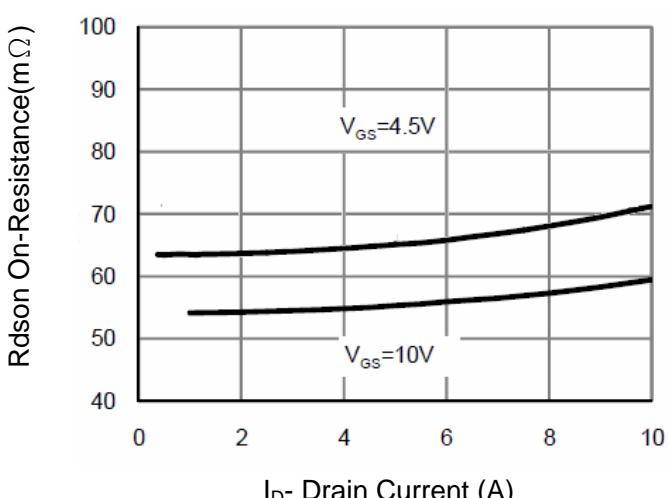


Figure 3 R_{DSON} - Drain Current

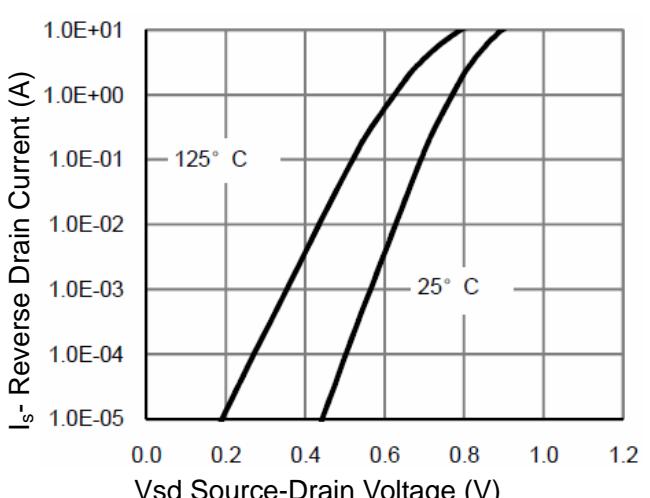


Figure 6 Source- Drain Diode Forward



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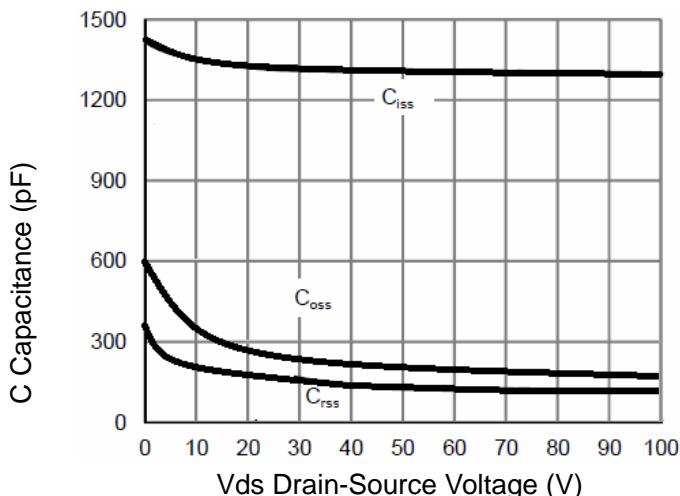


Figure 7 Capacitance vs Vds

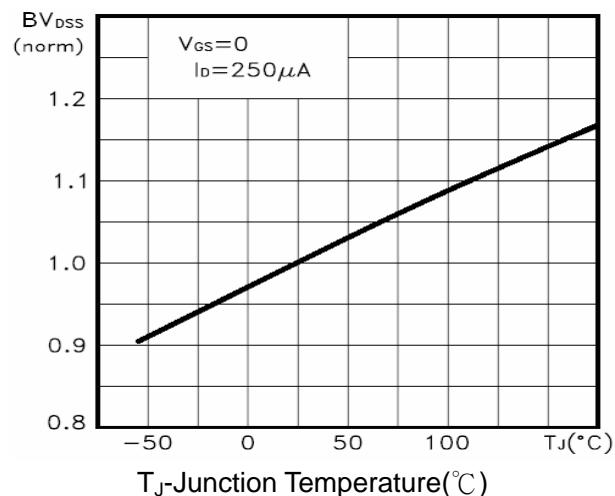


Figure 9 BV_{DSS} vs Junction Temperature

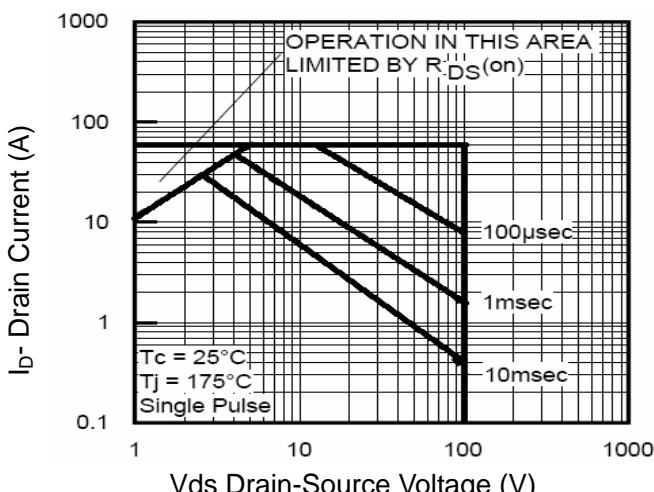


Figure 8 Safe Operation Area

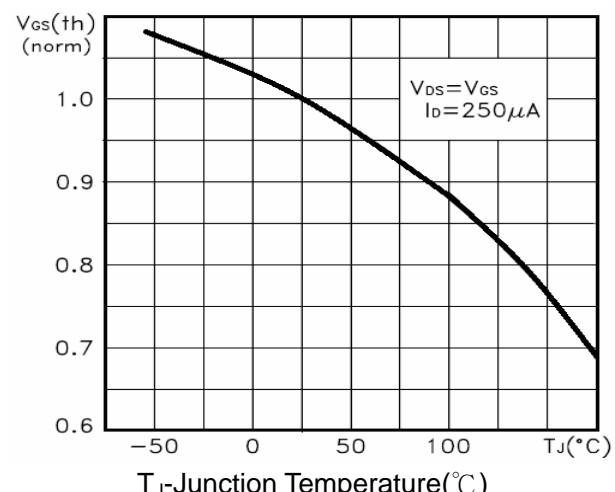


Figure 10 $V_{GS(th)}$ vs Junction Temperature

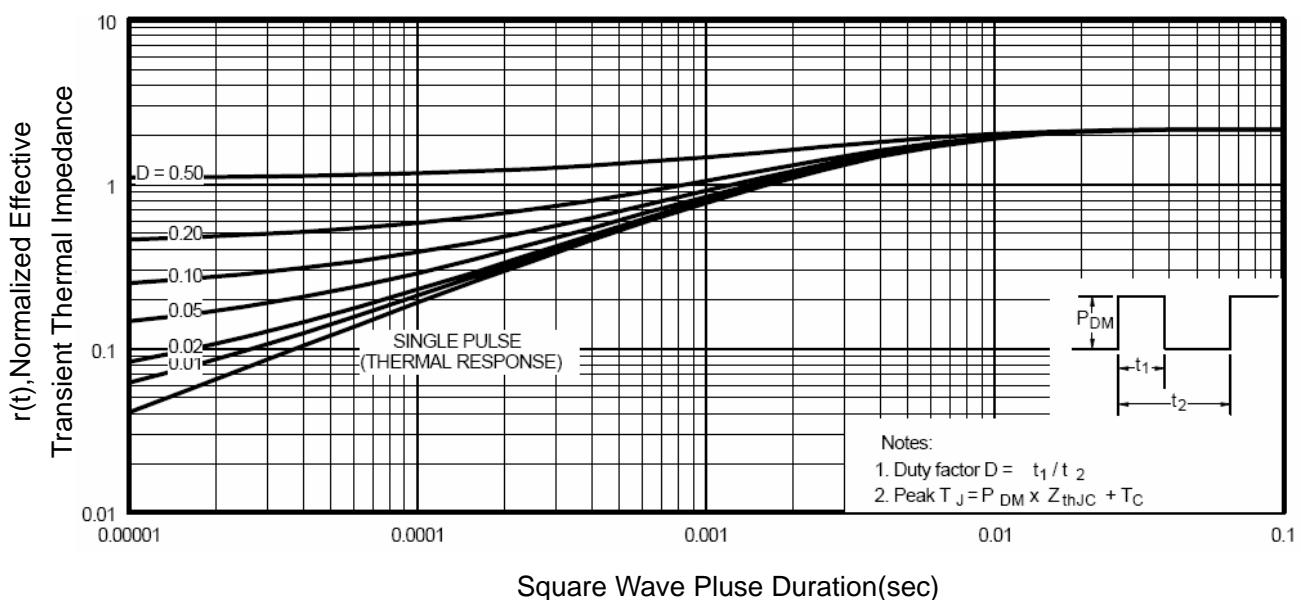


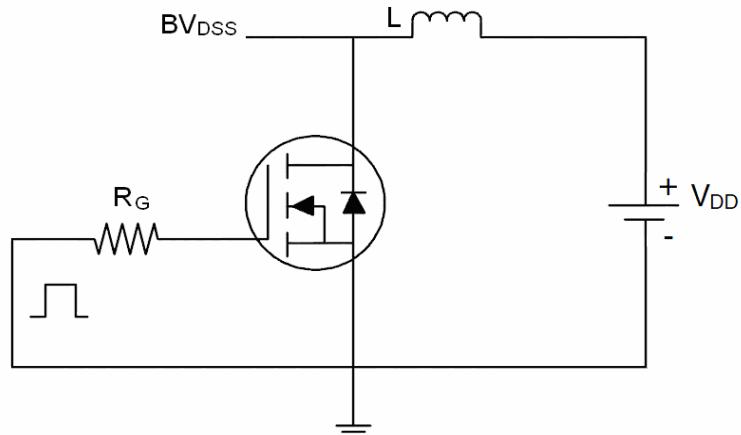
Figure 11 Normalized Maximum Transient Thermal Impedance



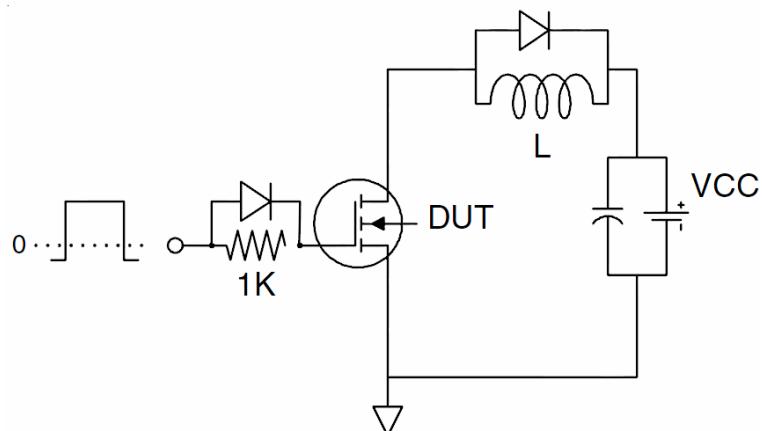
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Test Circuit

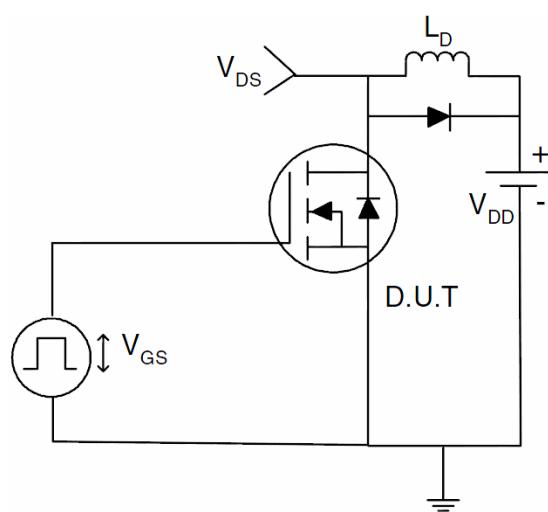
1) E_{AS} test Circuit



2) Gate charge test Circuit



3) Switch Time Test Circuit

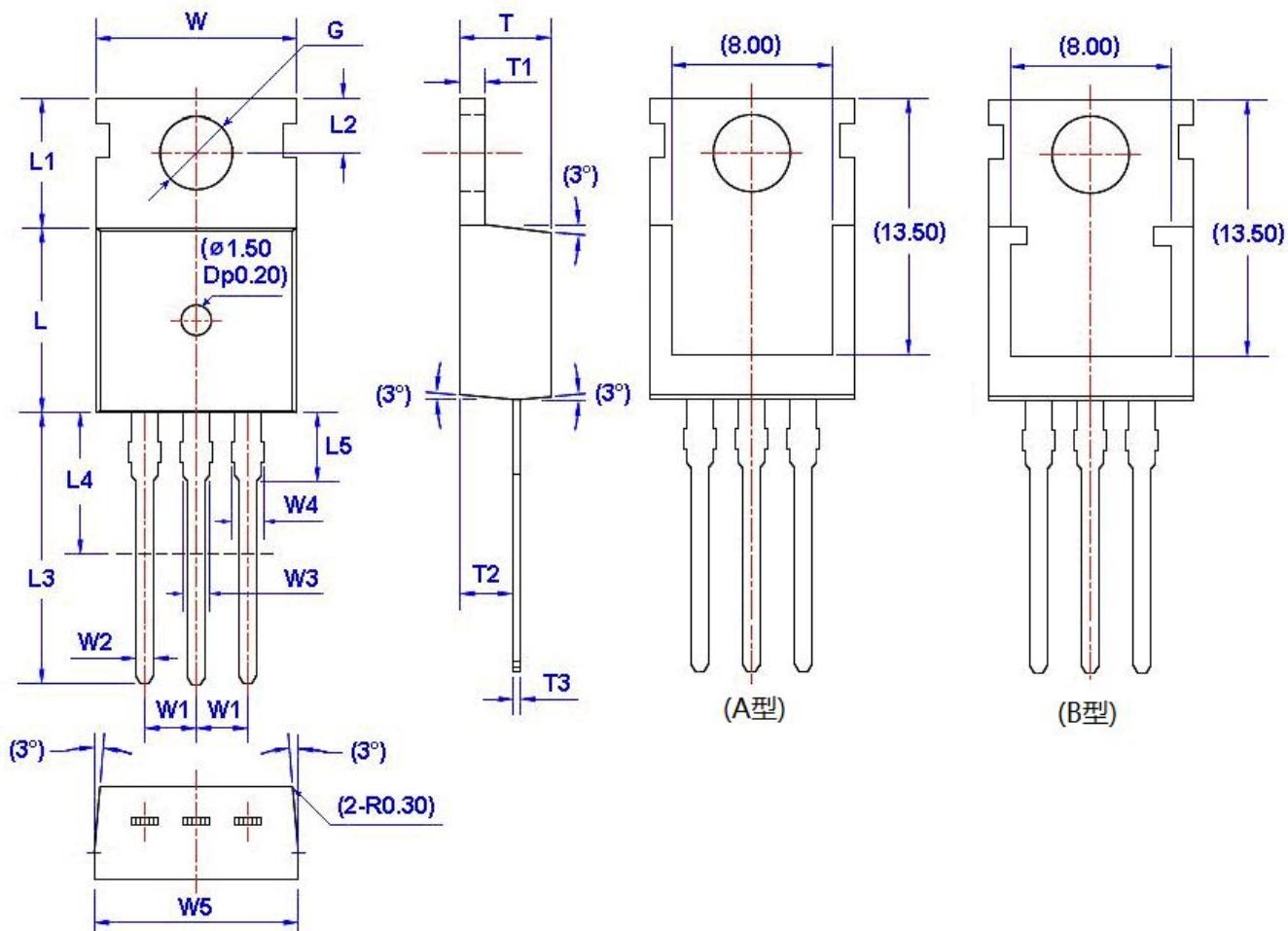




Package Dimension

TO-220

Unit:mm



Symbol	Size		Symbol	Size		Symbol	Size		Symbol	Size	
	Min	Max		Min	Max		Min	Max		Min	Max
W	9.66	10.28	W5	9.80	10.20	L4**	6.20	6.60	T3	0.45	0.60
W1	2.54 (TYP)		L	9.00	9.40	L5	2.79	3.30	G(Φ)	3.50	3.70
W2	0.70	0.95	L1	6.40	6.80	T	4.30	4.70			
W3	1.17	1.37	L2	2.70	2.90	T1	1.15	1.40			
W4*	1.32	1.72	L3	12.70	14.27	T2	2.20	2.60			